

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination ADIR ET AL.	
	Examiner Xiuqin Sun	Art Unit 2863	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0158720	08-2003	Liu, Wayne Biao	703/17
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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